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			Application Number	09/506,717-Conf. #9161	
			Filing Date	February 18, 2000	
			First Named Inventor	Harold E. Nelson	
			Art Unit	1631	
Examiner Name	E. S. Dejong				
Sheet	2	of	6	Attorney Docket Number	0103544.00135US2

ED	AT1*	US-6,219,622	04-17-2001	Schmidt et al.	
ED	AU1*	US-6,226,620	05-01-2001	Oon et al.	
ED	AV1*	US-6,236,989	05-22-2001	Mandyam et al.	
ED	AW1	US-6,240,374	05-29-2001	Cramer et al.	
ED	AX1*	US-6,246,410	06-12-2001	Bergeron et al.	
ED	AY1*	US-6,256,647	07-03-2001	Toh et al.	
ED	AZ1*	US-6,272,472	08-07-2001	Danneels et al.	
ED	AA2*	US-6,295,514	09-25-2001	Agrafiotis et al.	
ED	AB2*	US-6,323,852	11-27-2001	Blower, Jr. et al.	
ED	AC2*	US-6,324,522	11-27-2001	Peterson et al.	
ED	AD2*	US-6,326,962	12-04-2001	Szabo	
ED	AE2*	US-6,332,138	12-18-2001	Hull et al.	
ED	AF2*	US-6,341,314	01-22-2002	Doganata et al.	
ED	AG2*	US-6,453,064	09-17-2002	Aikawa et al.	
ED	AH2*	US-6,505,172	01-07-2003	Johnson et al.	
ED	AI2*	US-6,519,611	02-11-2003	Zong et al.	
ED	AJ2*	US-6,542,903	04-01-03-24-2003	Hull et al.	
ED	AK2*	US-6,584,412	06-24-2003	Brecher	
ED	AL2*	US-6,571,245	05-27-2003	Huang et al.	
ED	AM2*	US-6,618,852	09-09-2003	van Eikeren et al.	
ED	AN2*	US-6,631,381	10-07-2003	Couch et al.	
ED	AO2*	US-6,654,736	11-25-2003	Ellis et al.	
ED	AP2*	US-6,675,105	01-08-2004	Hogarth et al.	
ED	AQ2*	US-6,721,754	04-13-2004	Hurst et al.	
ED	AR2*	US-6,751,615	06-15-2004	Nisler et al.	
ED	AS2	US-US 2002/0049548	04-25-2002	Bunin	
ED	AT2	US-US 2002/0165853	11-07-2002	Gogalak	

380 8/17/07

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No.†	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T*
		Country Code* - Number* - Kind Code* (if known)				
ED	BA	WO-99/58474	11-18-1999	Swayze et al.		

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. † CITE NO.: Those application(s) which are marked with an asterisk (\*) next to the Cite No. are not supplied (under 37 CFR 1.98(a)(2)(ii)) because that application was filed after June 30, 2003 or is available in the (FW). † Applicant's unique citation designation number (optional). † See Kind Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. † Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). † For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. † Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. † Applicant is to place a check mark here if English language Translation is attached.

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ED	CA	Anonymous, "Databases Added to ChemWeb", <i>Information Today</i> , 2 pages, May, 1998	
ED	CB	BALASUBRAMANIAN, K.J., "Computer Perception of Molecular Symmetry", <i>J. Chem. Inf. Comput. Sci.</i> , Vol. 35, pp. 761-770, 1995	

Examiner Signature		Date Considered	
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